



# High Current Ferrite Chip Bead(Lead Free)

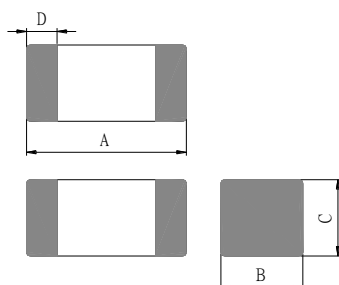
SFB2012HG-Sreies

## 1.Features

- 1.Monolithic inorganic material construction.
- 2.Low DC resistance structure of electrode to prevent wasteful electric power consumption.
- 3.Closed magnetic circuit avoids crosstalk.
- 4.Suitable for flow and reflow soldering.
- 5.Shapes and dimensions follow E.I.A. spec.
- 6.Available in various sizes.
- 7.Excellent solderability and heat resistance.
- 8.High reliability.
- 9.This component is compliant with RoHS legislation and also support lead-free soldering.



## 2.Dimensions



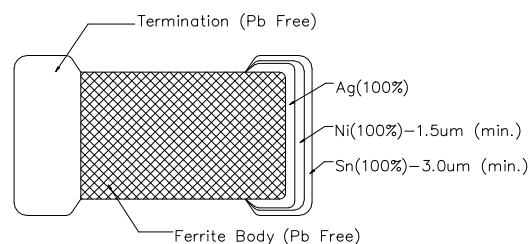
Chip Size	
A	2.00±0.20
B	1.25±0.20
C	0.85±0.20
D	0.50±0.30

Units: mm

## 3.Part Numbering

SFB
2012
HG
-
121
T
30

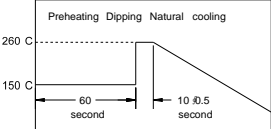
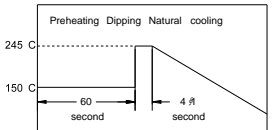
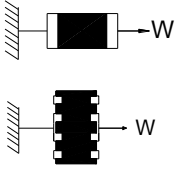
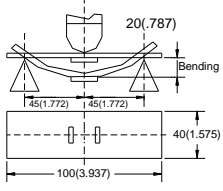
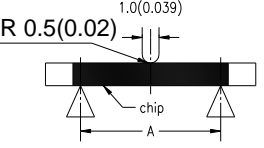
A: Series  
 B: Dimension L x W  
 C: Material [Lead Free Material](#)  
 D: Impedance [121=120Ω](#)  
 E: Packaging T=Taping and Reel, B=Bulk(Bags)  
 F: Rated Current [30=3000mA](#)



## 4. Specification

ISND Part Number	Impedance ( $\Omega$ )	Test Frequency (Hz)	DC Resistance ( $\Omega$ ) max.	Rated Current (mA) max.
SFB2012HG-100T30	10 $\pm$ 25%	60mV/100M	0.01	3000
SFB2012HG-100T60	10 $\pm$ 25%	60mV/100M	0.01	3000
SFB2012HG-300T50	30 $\pm$ 25%	60mV/100M	0.03	5000
SFB2012HG-420T40	42 $\pm$ 25%	60mV/100M	0.03	4000
SFB2012HG-500T30	50 $\pm$ 25%	60mV/100M	0.03	3000
SFB2012HG-600T30	60 $\pm$ 25%	60mV/100M	0.04	3000
SFB2012HG-700T30	70 $\pm$ 25%	60mV/100M	0.04	3000
SFB2012HG-800T30	80 $\pm$ 25%	60mV/100M	0.04	3000
SFB2012HG-800T60	80 $\pm$ 25%	60mV/100M	0.04	6000
SFB2012HG-101T30	100 $\pm$ 25%	60mV/100M	0.04	3000
SFB2012HG-121T30	120 $\pm$ 25%	60mV/100M	0.04	3000
SFB2012HG-121T60	120 $\pm$ 25%	60mV/100M	0.1	6000
SFB2012HG-221T20	220 $\pm$ 25%	60mV/100M	0.1	2000
SFB2012HG-301T20	300 $\pm$ 25%	60mV/100M	0.2	2000
SFB2012HG-301T40	300 $\pm$ 25%	60mV/100M	0.2	4000
SFB2012HG-331T20	330 $\pm$ 25%	60mV/100M	0.2	2000
SFB2012HG-471T10	470 $\pm$ 25%	60mV/100M	0.2	1000
SFB2012HG-601T20	600 $\pm$ 25%	60mV/100M	0.2	2000
SFB2012HG-102T15	1000 $\pm$ 25%	60mV/100M	0.2	1500

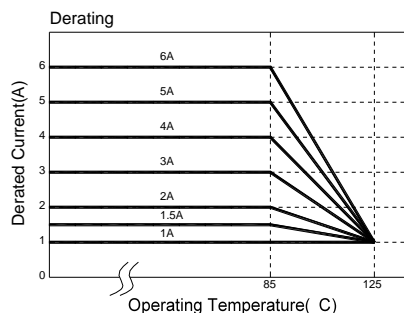
### 5. Reliability and Test Condition

Item	Performance		Test Condition																											
Series No.	SFB	HXCI	--																											
Operating Temperature	-55~+125°C (Including self-temperature rise)	-40~+85°C (Including self-temperature rise)	--																											
Storage Temperature	-55~+125°C	-40~+85°C	--																											
Impedance (Z)	Refer to standard electrical characteristics list		HP4291A, HP4287A+16092A																											
Inductance (Ls)																														
Q Factor																														
DC Resistance																														
Rated Current																														
Temperature Rise Test	30°C max. (ΔT)		1. Applied the allowed DC current. 2. Temperature measured by digital surface thermometer.																											
Solder heat Resistance	Appearance: No significant abnormality. Impedance change: Within ± 30%.	No mechanical damage. Remaining terminal electrode: 70% min.	Preheat: 150°C, 60sec. Solder: Sn-Ag3.0-Cu0.5 Solder temperature: 260±5°C Flux for lead free: rosin Dip time: 10±0.5sec. 																											
Solderability	More than 90% of the terminal electrode should be covered with solder.		Preheat: 150°C, 60sec. Solder: Sn-Ag3.0-Cu0.5 Solder temperature: 245±5°C Flux for lead free: rosin Dip time: 4±1sec.																											
Terminal strength	The terminal electrode and the dielectric must not be damaged by the forces applied on the right conditions.		For SFB HXCI : Size Force (Kgf) Time(sec) 1005 0.2 1608 0.5 2012 0.6 3216 1.0 >25 3225 1.0 4516 1.0 4532 1.5 5750 2.0 For HXCA: Size Force (Kgf) Time(sec) 3216 0.5 >25																											
Flexure strength	The terminal electrode and the dielectric must not be damaged by the forces applied on the right conditions.		Solder a chip on a test substrate, bend the substrate by 2mm (0.079in) and return.																											
Bending Strength	The ferrite should not be damaged by Forces applied on the right condition.		<table border="1"> <thead> <tr> <th>Size</th> <th>mm(inches)</th> <th>P-Kgf</th> </tr> </thead> <tbody> <tr> <td>1608</td> <td>0.80(0.033)</td> <td>0.3</td> </tr> <tr> <td>2012</td> <td>1.40(0.055)</td> <td>1.0</td> </tr> <tr> <td>HXCA3216</td> <td>2.00(0.079)</td> <td>1.5</td> </tr> <tr> <td>3216</td> <td>2.00(0.079)</td> <td>2.5</td> </tr> <tr> <td>3225</td> <td>2.00(0.079)</td> <td>2.5</td> </tr> <tr> <td>4516</td> <td>2.70(0.106)</td> <td>2.5</td> </tr> <tr> <td>4532</td> <td>2.70(0.106)</td> <td>2.5</td> </tr> <tr> <td>5750</td> <td>2.70(0.106)</td> <td>2.5</td> </tr> </tbody> </table>	Size	mm(inches)	P-Kgf	1608	0.80(0.033)	0.3	2012	1.40(0.055)	1.0	HXCA3216	2.00(0.079)	1.5	3216	2.00(0.079)	2.5	3225	2.00(0.079)	2.5	4516	2.70(0.106)	2.5	4532	2.70(0.106)	2.5	5750	2.70(0.106)	2.5
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Random Vibration Test	Appearance: Cracking, shipping and any other defects harmful to the characteristics should not be allowed. Impedance: within ±30%		Frequency: 10-55-10Hz for 1 min. Amplitude: 1.52mm Directions and times: X, Y, Z directions for 2 hours. A period of 2 hours in each of 3 mutually perpendicular directions (Total 6 hours).																											

Item	Performance	Test Condition
Loading at High Temperature	Appearance: no damage.	Temperature: 125±5°C (bead), 85±5°C (inductor) Applied current: rated current. Duration: 1008±12hrs. Measured at room temperature after placing for 2 to 3hrs.
Humidity	Impedance: within±30% of initial value. Inductance: within±10% of initial value. Q: within±30% of initial value. (HXCI)	Humidity: 90~95%RH. Temperature: 40±2°C. Temperature: 60±2°C. (HCI) Duration: 1008±12hrs. Measured at room temperature after placing for 2 to 3hrs.
Thermal shock	Appearance: no damage. Impedance: within±30% of initial value. Inductance: within±10% of initial value. Q: within±30% of initial value. (HXCI)	For SFB HXCA : Condition for 1 cycle Step1: -55±2°C 30±3 min. Step2: +125±5°C 30±3 min. Number of cycles: 5 For HXCI : Condition for 1 cycle Step1: -40±2°C 30±3 min. Step2: +85±5°C 30±3 min. Number of cycles: 100 Measured at room temperature after placing for 2 to 3 hrs.
Low temperature storage test		Temperature: -55±2°C. Duration: 1008±12hrs. Measured at room temperature after placing for 2 to 3hrs.
Drop	a: No mechanical damage b: Impedance change: ±30%	Drop 10 times on a concrete floor from a height of 75cm

**\*\*Derating Curve**

For the ferrite chip bead which withstanding current over 1.5A, as the operating temperature over 85°C, the derating current information is necessary to consider with. For the detail derating of current, please refer to the Derated Current vs. Operating Temperature curve.

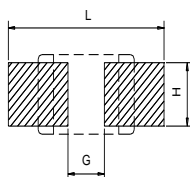
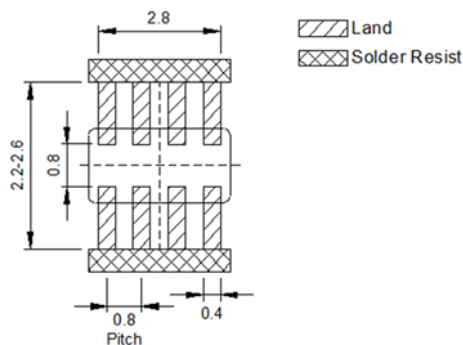


**6.Soldering and Mounting**

**6-1. Recommended PC Board Pattern**

Chip Size						Land Patterns For Reflow Soldering		
Series	Type	A(mm)	B(mm)	C(mm)	D(mm)	L(mm)	G(mm)	H(mm)
SFB	1005	1.0±0.10	0.50±0.10	0.50±0.10	0.25±0.10	2.10	0.50	0.55
SFB	1608	1.6±0.15	0.80±0.15	0.80±0.15	0.30±0.20	2.60	0.60	0.80
SFB	2012	2.0±0.20	1.25±0.20	0.85±0.20	0.50±0.30	3.00	1.00	1.00
SFB		2.0±0.20	1.25±0.20	1.25±0.20	0.50±0.30			
SFB	2520	2.5±0.20	2.00±0.20	1.60±0.20	0.50±0.30	3.90	1.50	1.50
SFB	3216	3.2±0.20	1.60±0.20	1.10±0.20	0.50±0.30	4.40	2.20	1.40
SFB	3225	3.2±0.20	2.50±0.20	1.30±0.20	0.50±0.30	4.40	2.20	3.40
SFB	4516	4.5±0.20	1.60±0.20	1.60±0.20	0.50±0.30	5.70	2.70	1.40
SFB	4532	4.5±0.20	3.20±0.20	1.50±0.20	0.50±0.30	5.90	2.57	4.22
SFB	5750	5.7±0.20	5.00±0.30	1.80±0.20	0.50±0.30	8.00	4.00	5.80

HXCA3216



PC board should be designed so that products are not sufficient under mechanical stress as warping the board. Products shall be positioned in the sideways direction against the mechanical stress to prevent failure.

### 6-2. Soldering

Mildly activated rosin fluxes are preferred. The terminations are suitable for re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.

Note.

If wave soldering is used, there will be some risk. Re-flow soldering temperatures below 240 degrees, there will be non-wetting risk

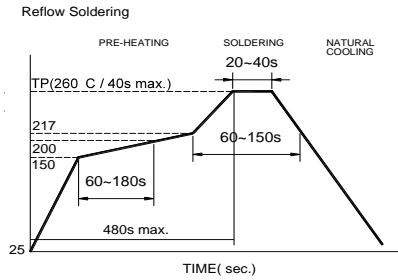
#### 6-2.1 Lead Free Solder re-flow:

Recommended temperature profiles for lead free re-flow soldering in Figure 1.

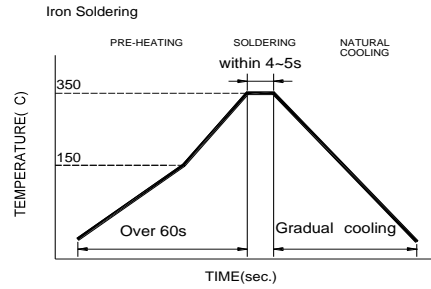
#### 6-2.2 Soldering Iron:

Products attachment with a soldering iron is discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precautions are recommended. for Iron Soldering in Figure 2.

- Preheat circuit and products to 150°C
- Never contact the ceramic with the iron tip
- Use a 20 watt soldering iron with tip diameter of 1.0mm
- 350°C tip temperature (max)
- 1.0mm tip diameter (max)
- Limit soldering time to 4-5sec.



Reflow times: 3 times max  
Fig.1

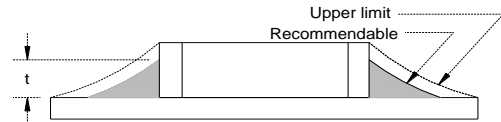


Iron Soldering times : 1 times max  
Fig. 2

#### 6-2.3 Solder Volume:

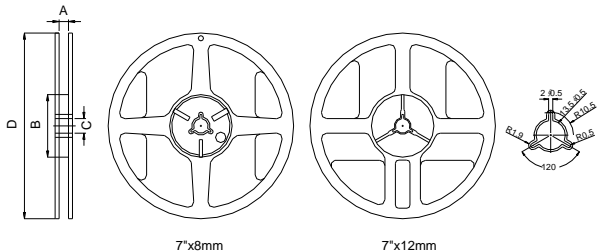
Accordingly increasing the solder volume, the mechanical stress to product is also increased. Exceeding solder volume may cause the failure of mechanical or electrical performance. Solder shall be used not to be exceed as shown in right side:

Minimum fillet height = soldering thickness + 25% product height



## 7.Packaging Information

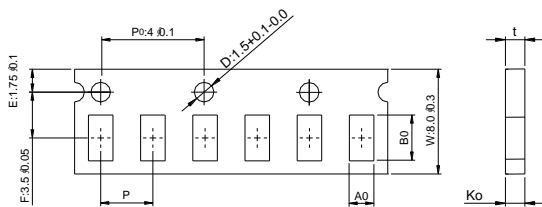
### 7-1. Reel Dimension



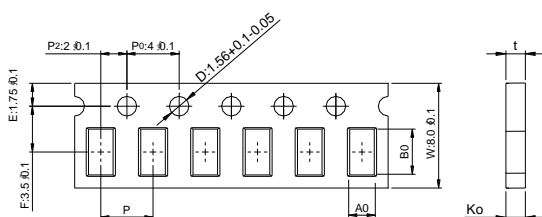
Type	A(mm)	B(mm)	C(mm)	D(mm)
7"x8mm	9.0±0.5	60±2	13.5±0.5	178±2
7"x12mm	13.5±0.5	60±2	13.5±0.5	178±2

#### 7-2.1 Tape Dimension / 8mm

Material of taping is paper

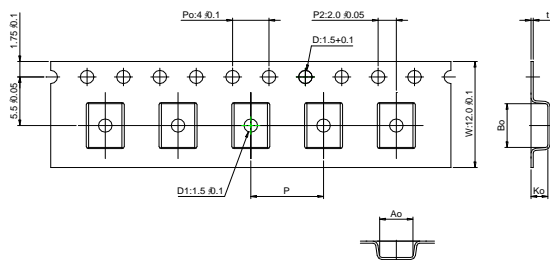


Size	Bo(mm)	Ao(mm)	Ko(mm)	P(mm)	t(mm)	D1(mm)
060303	0.68±0.05	0.38±0.05	0.50max	2.0±0.05	0.50max	none



Size	Bo(mm)	Ao(mm)	Ko(mm)	P(mm)	t(mm)	D1(mm)
100505	1.12±0.03	0.62±0.03	0.60±0.03	2.0±0.10	0.60±0.03	none
160808	1.85±0.05	1.05±0.05	0.95±0.05	4.0±0.10	0.95±0.05	none
201209	2.30±0.05	1.50±0.05	0.95±0.05	4.0±0.10	0.95±0.05	none

7-2.2 Tape Dimension / 12mm

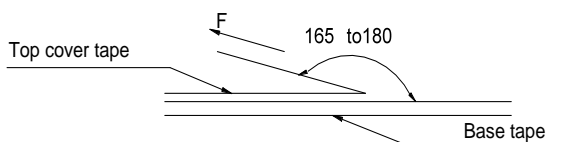


Series	Size	Bo(mm)	Ao(mm)	Ko(mm)	P(mm)	t(mm)	D1(mm)
SFB,	451616	4.95±0.1	1.93±0.1	1.93±0.1	4.0±0.1	0.24±0.05	1.5±0.1
	453215	4.95±0.1	3.66±0.1	1.85±0.1	8.0±0.1	0.24±0.05	1.5±0.1
HXCI	575018	6.10±0.1	5.40±0.1	2.00±0.1	8.0±0.1	0.30±0.05	1.5±0.1

7-3. Packaging Quantity

Chip Size	575018	453215	451616	322513	321611	201212	201209	160808	100505
Chip / Reel	1000	1000	2000	2500	3000	2000	4000	4000	10000
Inner box	4000	4000	8000	12500	15000	10000	20000	20000	50000
Middle box	20000	20000	40000	62500	75000	50000	100000	100000	250000
Carton	40000	40000	80000	125000	150000	100000	200000	200000	500000
Bulk (Bags)	7000	12000	20000	30000	50000	100000	150000	200000	300000

7-4. Tearing Off Force



The force for tearing off cover tape is 15 to 60 grams in the arrow direction under the following conditions.

Room Temp. (°C)	Room Humidity (%)	Room atm (hPa)	Tearing Speed mm/min
5-35	45-85	860-1060	300

**Application Notice**

·Storage Conditions

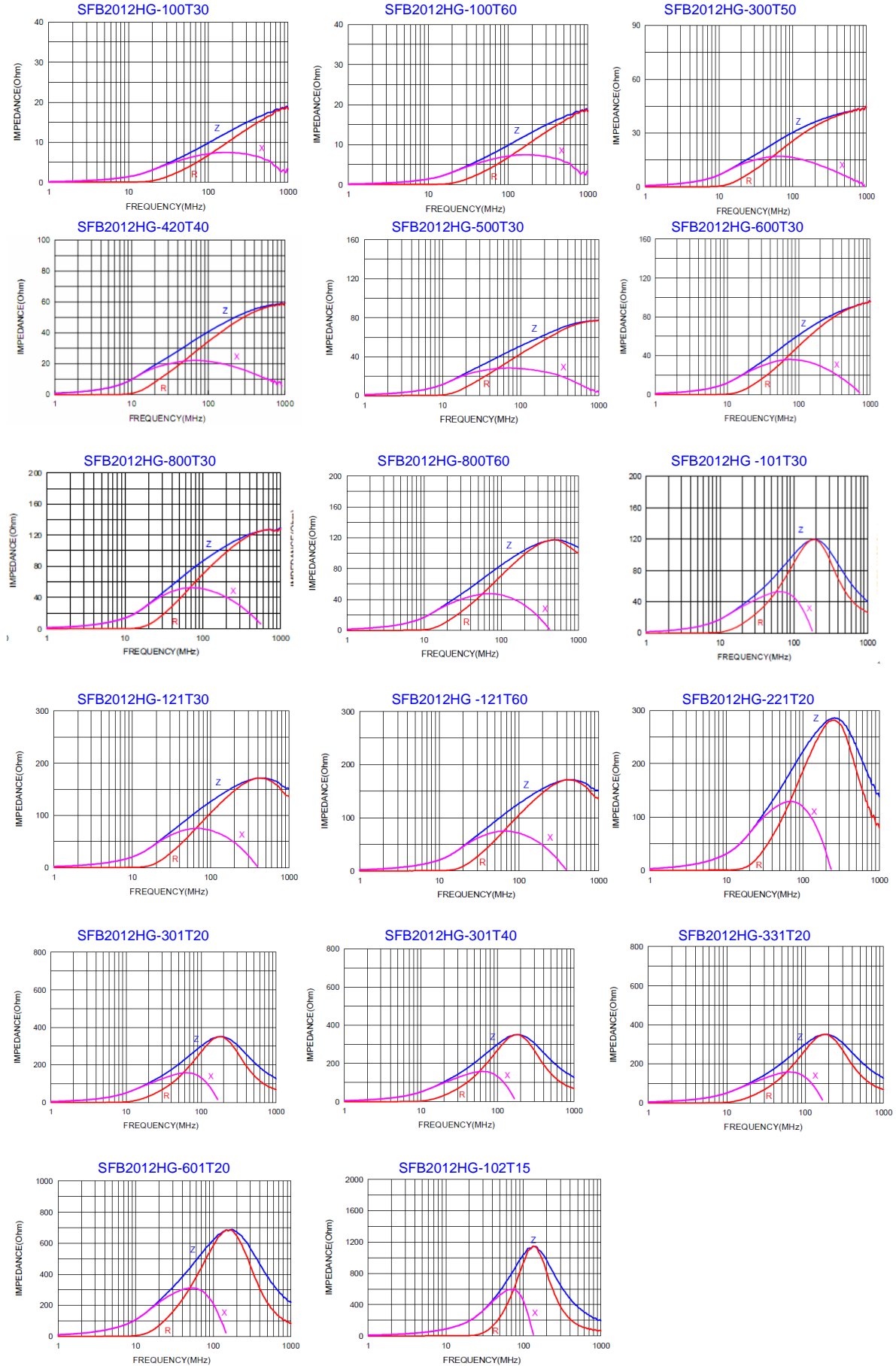
To maintain the solderability of terminal electrodes:

1. Temperature and humidity conditions: -10~ 40°C and 30~70% RH.
2. Recommended products should be used within 6 months from the time of delivery.
3. The packaging material should be kept where no chlorine or sulfur exists in the air.

·Transportation

1. Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
3. Bulk handling should ensure that abrasion and mechanical shock are minimized.

## Impedance Frequency Characteristics(Typical)





单击下面可查看定价，库存，交付和生命周期等信息

[>>ISND\(华信安\)](#)